

EMB-LN8T

Temperature/Humidity Test Report

Report NO: 11I020022

Summary	<p><input checked="" type="checkbox"/> Pass</p> <p><input type="checkbox"/> Fail</p> <p>Note : There is/are ____ defect(s) not list in the report, please check it in the DTS Website.</p> <p><input type="checkbox"/> Pass with Deviation</p> <p>Comment: _____</p>
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Issue date

2011-08-05

Approval

Jansin Lee

Test Engineer

Rex Chang

Test item list

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Testing Result

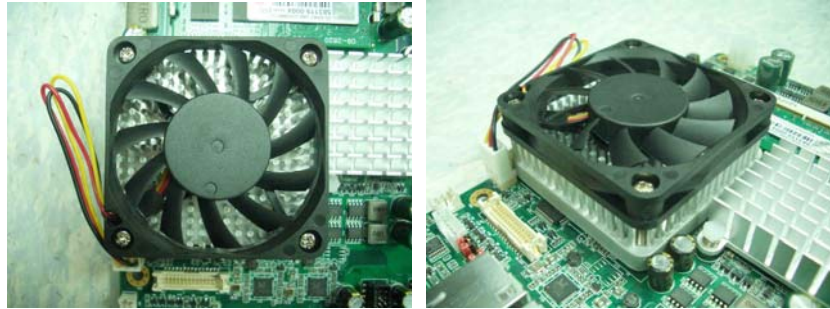
Num	Test item list	Result	Remark
1	Temp./humidity power on/off test	Pass	
2	Temperature variation operation test	Pass	
3	Cold start and hot start test	Pass	

Configuration of EUT

Test Product: EMB-LN8T A0.3_0_0

Sample Configuration & Quantity Under Test:

1. CPU: Intel Atom D525 / 1.8GHz (Bios Ver.ELN-8T 0.10 X64)
2. Chipset: Intel PineView D / ICH8M
3. VGA: Intel PineView D / ICH8M
4. Memory: Transcend 2GB / DDR3-1066 / Hynix H5TQ2G830A H9C 105A
5. CFD: PQI 32MB (for DOS mode power on/off test)
6. 2.5" SATA HDD: TOSHIBA MK1165GSX / 160GB
7. Test Software: Windows XP / Run PassMark Burn In Test 6.0 Pro
8. AT Power Supply - Zippy SP2-4300F to ATX Mode
9. CPU Cooler:



Temp./humidity power on/off test

Test Date: 08-04~05-2011

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-30 Testing procedures
Test Db: Damp Heat Test

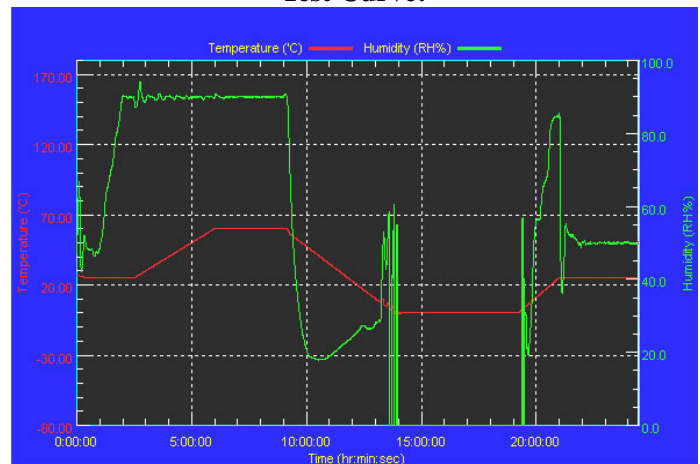
Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-B6T-150+LN2
Date of Calibration: 04/28/11
Serial Number: 6488KT

Temperature & Humidity Power On/Off Test:

Testing Specification:

Step	Temperature (°C)	Humidity (%RH)	Duration (HH:MM)
1	25	50	00:30
2	25	50	00:30
3	25	90	01:00
4	25	90	00:30
5	60	90	03:30
6	60	90	03:00
7	0	0	04:50
8	0	0	05:23
9	25	50	01:47
10	25	50	03:00

Test Curve:



Test Result:

Test Method	Actual	Successful	Failure rate
Power On/Off	1214/times	1214/times	0 %

Note: Failure rate need to under 0.2%.

Temperature variation operation test

Test Date: 08-03~04-2011

Test Site: AAEON QE Internal Lab.

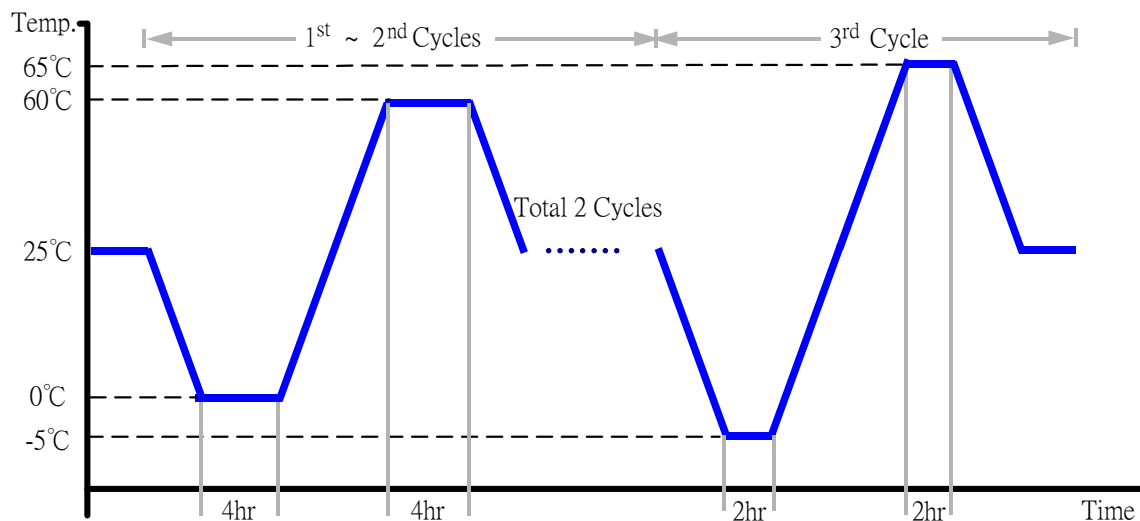
Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:

Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-B6T-150+LN2
Date of Calibration: 04/28/11
Serial Number: 6488KT

Temperature & Humidity Cycle Test:

1. Test Low Temperature: 0°C (1~2 cycles)
-5°C (3rd cycle)
2. Test High Temperature: 60°C (1~2 cycles)
65°C (3rd cycle)
3. Test dwell time: 4Hrs (1~2 cycles)
2Hrs (3rd cycle)
4. Temperature slope: 2°C/min
5. Test cycle: 3 cycles
6. Test Environment Curve:



Test Result:

No problem was found during the temperature variation operation test.

Cold start and hot start test

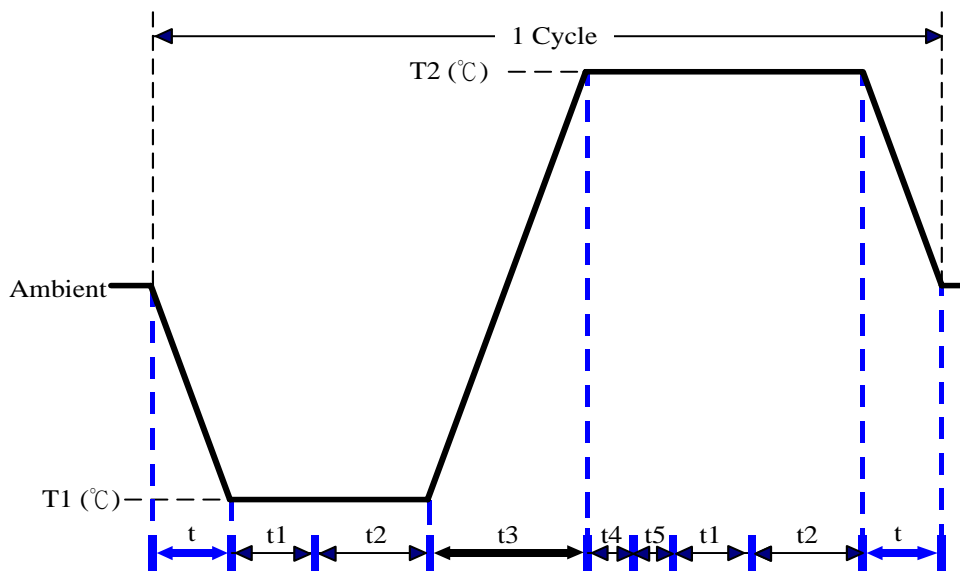
Test Date: 08-02~03-2011

Test Site: AAEON QE Internal Lab.

Test Standard: Reference IEC 68-2-14 Testing procedures
Test N: Change of temperature Test

Test Equipment:
Programmable Temperature & Humidity Chamber
K.SON. INS. TECH. CORP.
Model: THS-B6T-150+LN2
Date of Calibration: 04/28/11
Serial Number: 6488KT

Test Condition:



Parameters	Description
T1	-5°C
T2	65°C
t1	1 hrs
t2	2 hrs
t4, t5	30 min
t, t3	2°C/min
n (Cycle)	1

t,t3 = temprature slope
t, t1: Power Off
t2: Power on/off test 10 times (on 2 min / off 5min)
t3,t4: Run PassMark Burn In Test
t5: Win XP Software restart test 2 times
Test Software:Windows XP

Test Result:

- a. No problem was found during the cold start test.
- b. No problem was found during the hot start test.